

# APPLICATION NOTE

MITSUBISHI<IGBT MODULE>

## Tentative

CM150RL-12NF

Pre.	M.Koura	Rev	B	H.Hanada, H.Koura
Apr.	T.Furue 27-Nov-'03			T.furue 20-May-'04

HIGH POWER SWITCHING USE

Notice : This is not a final specification. Some parametric limits are subject to change.

CM150RL-12NF
● $I_c$ .....150A
● $V_{CES}$ ..... 600V
●Insulated Type
●7-elements in a pack

### APPLICATION

AC drive inverters & Servo controls,etc

### ABSOLUTE MAXIMUM RATINGS ( $T_j = 25\text{ }^\circ\text{C}$ )

Inverter part

Symbol	Item	Conditions	Ratings	Units
$V_{CES}$	Collector-emitter voltage	G-E Short	600	V
$V_{GES}$	Gate-emitter voltage	C-E Short	$\pm 20$	
$I_c$	Collector current	DC, $T_c=93^\circ\text{C}^*1$	150	A
$I_{CM}$		Pulse (2)	300	
$I_E$ (1)	Emitter current		150	
$I_{EM}$ (1)		Pulse (2)	300	
$P_c$ (3)	Maximum collector dissipation	$T_c=25\text{ }^\circ\text{C}$	730	W

Brake part

Symbol	Item	Conditions	Ratings	Units
$V_{CES}$	Collector-emitter voltage	G-E Short	600	V
$V_{GES}$	Gate-emitter voltage	C-E Short	$\pm 20$	
$I_c$	Collector current	DC, $T_c=102^\circ\text{C}^*1$	75	A
$I_{CM}$		Pulse (2)	150	
$P_c$ (3)	Maximum collector dissipation	$T_c=25\text{ }^\circ\text{C}$	430	W
$V_{RRM}$	Repetitive peak reverse voltage	Clamp diode part	600	V
$I_{FM}$	Forward current	Clamp diode part	75	A

(Common rating)

Symbol	Item	Conditions	Ratings	Units
$T_j$	Junction temperature		$-40\sim+150$	$^\circ\text{C}$
$T_{stg}$	Storage temperature		$-40\sim+125$	
Viso	Isolation voltage	Main terminal to base plate,AC 1 min.	2500	V
—	Torque strength	Main terminal M5	2.5~3.5	N·m
—	Torque strength	Mounting holes M5	2.5~3.5	
—	Weight	Typical value	350	g

**CM150RL-12NF**  
 HIGH POWER SWITCHING USE
ELECTRICAL CHARACTERISTICS ( $T_j = 25\text{ }^\circ\text{C}$ )

Inverter part

Symbol	Item	Conditions	Min.	Typ.	Max.	Units	
$I_{CES}$	Collector cutoff current	$V_{CE}=V_{CES}, V_{GE}=0V$	—	—	1	mA	
$V_{GE(th)}$	Gate-emitter threshold voltage	$I_C=15mA, V_{CE}=10V$	6	7	8	V	B
$I_{GES}$	Gate leakage current	$V_{GE}=V_{GES}, V_{CE}=0V$	—	—	0.5	$\mu A$	
$V_{CE(sat)}$	Collector to emitter saturation voltage	$T_j = 25\text{ }^\circ\text{C}$   $I_C = 150A$	—	1.7	2.2	V	
		$T_j = 125\text{ }^\circ\text{C}$   $V_{GE} = 15V$	—	1.7	—		
$C_{ies}$	Input capacitance	$V_{CE} = 10V$ $V_{GE} = 0V$	—	—	23	nF	
$C_{oes}$	Output capacitance		—	—	2.8		
$C_{res}$	Reverse transfer capacitance		—	—	0.9		
$Q_G$	Total gate charge	$V_{CC}=300V, I_C=150A, V_{GE}=15V$	—	600	—	nC	
$t_{d(on)}$	Turn-on delay time	$V_{CC}=300V, I_C=150A$ $V_{GE1}=V_{GE2}=15V$ $R_G=4.2\Omega$ , Inductive load switching operation $I_E=150A$	—	—	120	ns	A
$t_r$	Turn-on rise time		—	—	100		
$t_{d(off)}$	Turn-off delay time		—	—	300		
$t_f$	Turn-off fall time		—	—	300		
$t_{rr}$ ①	Reverse recovery time		—	—	150		
$Q_{rr}$ ①	Reverse recovery charge	—	2.5	—	$\mu C$	A	
$V_{EC}$ ①	Emitter-collector voltage	$I_E=150A, V_{GE}=0V$	—	—	2.8	V	B
$R_{th(j-c)Q}$	Thermal resistance	IGBT part (1/6 module) *1	—	—	0.17	$^\circ\text{C/W}$	
$R_{th(j-c)R}$	Thermal resistance	FWDi part (1/6 module) *1			0.31		
$R_{th(c-f)}$	Contact thermal resistance	Case to fin, Thermal compound Applied (1/6 module) *2	—	0.085	—		
$R_G$	External gate resistance		4.2	—	42	$\Omega$	

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## mitsubishi<IGBT MODULE> CM150RL-12NF HIGH POWER SWITCHING USE

### Brake Part

Symbol	Item	Conditions	Min.	Typ.	Max.	Units
$I_{CES}$	Collector cutoff current	$V_{CE}=V_{CES}, V_{GE}=0V$	—	—	1	mA
$V_{GE(th)}$	Gate-emitter threshold voltage	$I_C=7.5mA$	6	7	8	V
$I_{GES}$	Gate leakage current	$V_{GE}=V_{GES}, V_{CE}=0V$	—	—	0.5	$\mu A$
$V_{CE(sat)}$	Collector to emitter saturation voltage	$T_j=25^\circ C$ $I_C=75A$	—	1.7	2.2	V
		$T_j=125^\circ C$ $V_{GE}=15V$	—	1.7	—	
$C_{ies}$	Input capacitance	$V_{CE}=10V$ $V_{GE}=0V$	—	—	11.3	nF
$C_{oes}$	Output capacitance		—	—	1.4	
$C_{res}$	Reverse transfer capacitance		—	—	0.45	
$Q_G$	Total gate charge	$V_{CC}=300V, I_C=75A, V_{GE}=15V$	—	300	—	nC
$V_{FM}$	Forward voltage drop	$I_F=75A$	—	—	2.6	V
$R_{th(j-c)Q}$	Thermal resistance	IGBT part *1	—	—	0.29	$^{\circ}C/W$
$R_{th(j-c)R}$		Clamp diode part *1	—	—	0.51	

\*1:  $T_c$  measured point is just under the chips.

if you use this value,  $R_{th(f-a)}$  should be measured just under the chips.

\*2: Typical value is measured by using Shin-etsu Silicone "G-746".

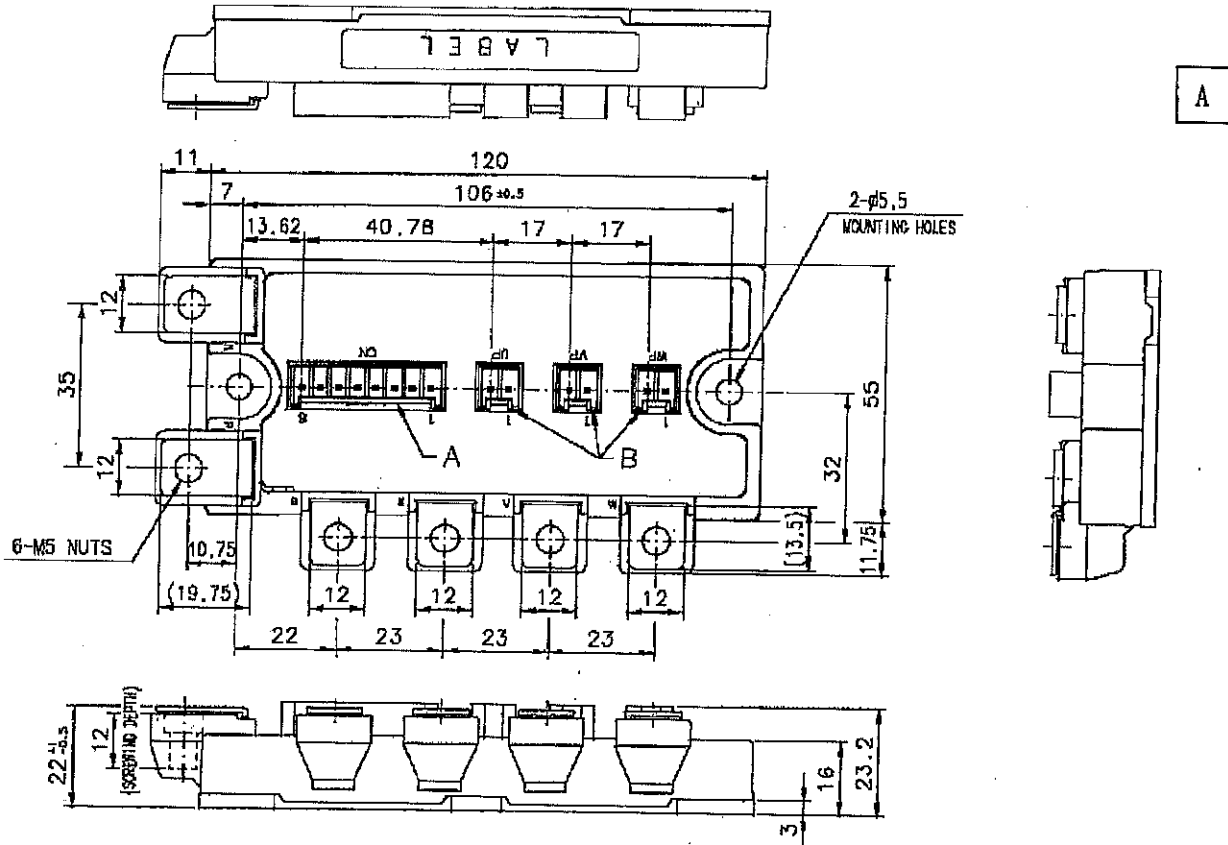
- ①  $I_E, V_{EC}, t_{rr}, Q_{rr}$  represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD).
- ② Pulse width and repetition rate should be such that the device junction temp. ( $T_j$ ) dose not exceed  $T_{jmax}$  rating.
- ③ Junction temperature ( $T_j$ ) should not increase beyond  $150^{\circ}C$ .
- ④ Pulse width and repetition rate should be such as to cause negligible temperature rise.

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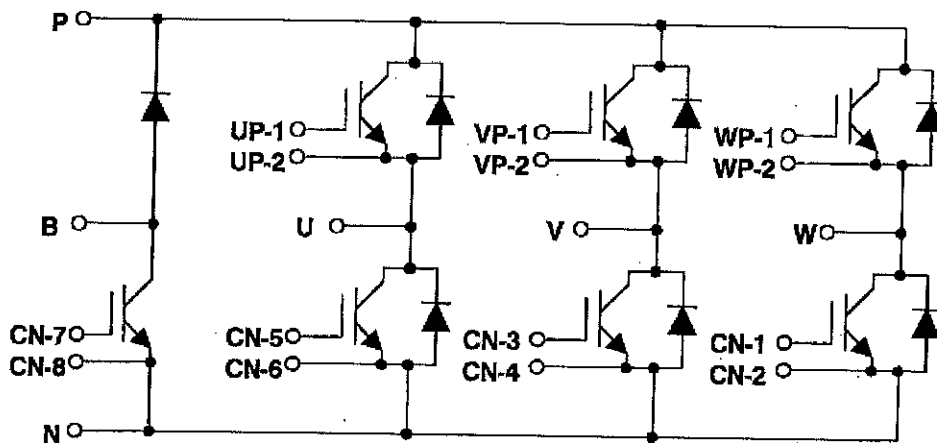
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**CM150RL-12NF**  
 HIGH POWER SWITCHING USE

## OUTLINE DRAWING

Dimensions in mm



## CIRCUIT DIAGRAM

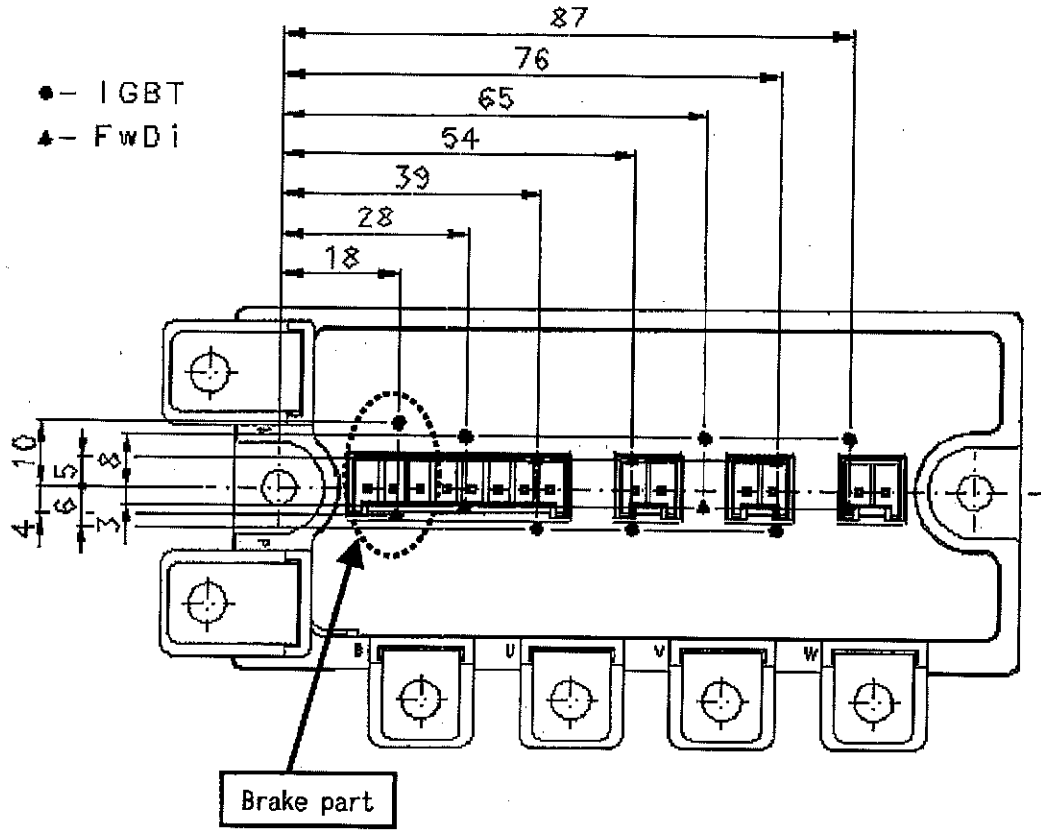


APPLICATION NOTE

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CHIP LAYOUT DRAWING

Dimensions in mm



B